Notice of References Cited Application/Control No. 10/550,838 Applicant(s)/Patent Under Reexamination YAMASHITA ET AL. Examiner Alvin L. Carlos 3714 Applicant(s)/Patent Under Reexamination YAMASHITA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | Α | US-3,213,550 A | 10-1965 | KITTNER FRANK M | 434/273 |
| * | В | US-3,916,535 A | 11-1975 | Hewson, Carl | 434/265 |
| * | С | US-4,209,919 A | 07-1980 | Kirikae et al. | 434/270 |
| * | D | US-4,484,896 A | 11-1984 | Kohnke, Ole B. | 434/265 |
| * | Е | US-4,708,836 A | 11-1987 | Gain et al. | 264/40.1 |
| * | F | US-5,090,910 A | 02-1992 | Narlo, Jeanie R. | 434/82 |
| * | G | US-5,803,746 A | 09-1998 | Barrie et al. | 434/267 |
| * | Н | US-5,846,087 A | 12-1998 | Scherer, Andrew J. | 434/270 |
| * | ı | US-6,103,156 A | 08-2000 | Holtzberg, Matthew W. | 264/102 |
| * | J | US-2001/0019818 A1 | 09-2001 | Yong, Peter | 434/262 |
| * | К | US-2003/0039676 A1 | 02-2003 | Boyce et al. | 424/423 |
| * | L | US-6,957,961 B1 | 10-2005 | Owens et al. | 434/270 |
| * | М | US-2006/0235562 A1 | 10-2006 | Knoppers et al. | 700/119 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | 2 | | | | | |
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NON-PATENT DOCUMENTS

| | NOVI A PRODUCTION | | | | | | | |
|---|-------------------|---|--|--|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | | |
| | U | | | | | | | |
| | v | | | | | | | |
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| | x | | | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.